

No. 2013EEB00055-1

For

VeryKool USA INC.

Mobile phone

Model name: RS90

With

Hardware Version: V301-KQAM00D1-2

Software Version: RS90_Verykool_Gen_Dual_V1.0

FCC ID: WA6RS90

Results Summary: M Category = M4 (for WCDMA 850/1900)

Issued Date: 2013-04-17

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of TMC Beijing.

Test Laboratory:

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1 Test Laboratory

1.1 Testing Location

Company Name:

TMC Shenzhen, Telecommunication Metrology Center of MIIT

Address:

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District, Shenzhen, P. R. China

Postal Code:

518048

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1.2 Testing Environment

Temperature:

18°C~25 °C,

Relative humidity:

30%~ 70%

Ground system resistance:

< 0.5 Ω

Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.

1.3 Project Data

Project Leader:

Zhou Yi

Test Engineer:

Zhu Zhiqiang

Testing Start Date:

Mar 19 th, 2013

Testing End Date:

Mar 21 th, 2013

1.4 Signature

Zhu Zhiqiang

(Prepared this test report)

Zhou Yi

(Reviewed this test report)

Lu Minniu

Director of the laboratory (Approved this test report)



2 Client Information

2.1 Applicant Information

Company Name: VeryKool USA INC.

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City: /
Postal Code: /

Country: USA

Contact: Sunny Choi

E-mail: sunny.choi@infosonics.com

Telephone: +1 858 373 1635 Fax: +1 858 373 1505

2.2 Manufacturer Information

Company Name: VeryKool USA INC.

Address /Post: 3636 Nobel Drive, Suite 325 San Diego, CA 92122

City: /
Postal Code: /
Country: USA

Contact: Sunny Choi

E-mail: sunny.choi@infosonics.com

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3 Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1 About EUT

Description:	Mobile phone				
Model name:	RS90				
Marketing name:	RS90				
Operating mode(s):	WCDMA 850/1900				
Tooted Ty Fraguency:	826.4-846.6MHz(WCDMA 850)				
Tested Tx Frequency:	1852.4-1908MHz(WCDMA 1900)				
Test Modulation	(WCDMA)QPSK				
Power class:	WCDMA: class 3, tested with power control all up bits				
Test device Production information:	Production unit				
Device type:	Portable device				
Antenna type:	Integrated antenna				
Form factor:	142mm* 75mm*12mm				

3.2 Internal Identification of EUT used during the test

EUT ID* SN or IMEI HW Version SW Version

EUT1 354728046454698 V301-KQAM00D1-2 RS90 Verykool Gen Dual V1.0

*EUT ID: is used to identify the test sample in the lab internally.

3.3 Internal Identification of AE used during the test

AE ID* Description Model SN Manufacturer

AE1 Battery 525159AR / Guangzhou TWS

Electronics Limited



4 CONDUCTED OUTPUT POWER MEASUREMENT

4.1 Summary

During the process of testing, the EUT was controlled via Rhode & Schwarz Digital Radio Communication tester (CMU-200) to ensure the maximum power transmission and proper modulation. This result contains conducted output power for the EUT. In all cases, the measured output power should be greater and within 5% than EMI measurement.

4.2 Conducted Power

WCDMA 850MHz	Conducted Power (dBm)									
	Channel 4233(846.6MHz)	Channel 4183(836.6MHz)	Channel 4132(826.4MHz)							
OSUIVINZ	22.46	22.54	22.45							
MCDMA		Conducted Power (dBm)								
WCDMA	Channel 9538(1907.6MHz)	Channel 9400(1880MHz)	Channel 9262(1852.4MHz)							
1900MHz	23.22	23.11	23.57							

5. Reference Documents

5.1Reference Documents for testing

The following document listed in this section is referred for testing.

Reference Title Version
ANSI C63.19-2007 American National Standard for Methods of Measurement of Compatibility between Wireless Communication Devices and Hearing Aids



6 OPERATIONAL CONDITIONS DURING TEST

6.1 HAC MEASUREMENT SET-UP

These measurements are performed using the DASY5 NEO automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and remote control, is used to drive the robot motors. The PC consists of the HP Intel Core2 1.86 GHz computer with Windows XP system and HAC Measurement Software DASY5 NEO, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

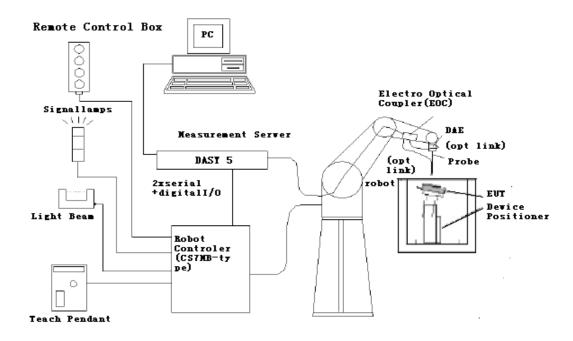


Fig. 1 HAC Test Measurement Set-up

The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.



6.2 Probe Specification

6.2.1 E-Field Probe Description

Construction One dipole parallel, two dipoles normal to probe axis

Built-in shielding against static charges

PEEK enclosure material

Calibration In air from 100 MHz to 3.0 GHz (absolute accuracy ±6.0%,

k=2)

Frequency 40 MHz to > 6 GHz (can be extended to < 20 MHz)

Linearity: ± 0.2 dB (100 MHz to 3 GHz)

Directivity ± 0.2 dB in air (rotation around probe axis)

± 0.4 dB in air (rotation normal to probe axis)

Dynamic Range 2 V/m to > 1000 V/m; Linearity: ± 0.2 dB

Dimensions Overall length: 330 mm (Tip: 16 mm)

Tip diameter: 8 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 2.5 mm

Application General near-field measurements up to 6 GHz

Field component measurements

Fast automatic scanning in phantoms

6.2.2 H-Field Probe Description

Construction Three concentric loop sensors with 3.8 mm loop diameters

Resistively loaded detector diodes for linear response

Built-in shielding against static charges

PEEK enclosure material (resistant to organic solvents,

e.g., glycolether)

Frequency 200 MHz to 3 GHz (absolute accuracy ± 6.0%, k=2); Output

linearized

Directivity ± 0.2 dB (spherical isotropy error)

Dynamic Range 10 mA/m to 2 A/m at 1 GHz

E-Field Interference < 10% at 3 GHz (for plane wave)

Dimensions Overall length: 330 mm (Tip: 40 mm)

Tip diameter: 6 mm (Body: 12 mm)

Distance from probe tip to dipole centers: 3 mm

Application General magnetic near-field measurements up to 3 GHz (in

air or liquids)

Field component measurements Surface current measurements

Low interaction with the measured field



[ER3DV6]



[H3DV6]



6.3 Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: $370 \times 370 \times 370 \text{ mm}$).

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.



Fig. 2 HAC Phantom & Device Holder

6.4 Robotic System Specifications

Specifications

Positioner: Stäubli Unimation Corp. Robot Model: TX90L

Repeatability: ±0.02 mm

No. of Axis: 6

Data Acquisition Electronic (DAE) System

Cell Controller

Processor: Intel Core2 Clock Speed: 1.86 GHz

Operating System: Windows XP

Data Converter

Features: Signal Amplifier, multiplexer, A/D converter, and control logic

Software: DASY5 software

Connecting Lines: Optical downlink for data and status info.

Optical uplink for commands and clock



7 EUT ARRANGEMENT

7.1 WD RF Emission Measurements Reference and Plane

Figure 4 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids.
- The grid is centered on the audio frequency output transducer of the WD (speaker or T-coil).
- The grid is located by reference to a reference plane. This reference plane is the planar area that contains the highest point in the area of the WD that normally rests against the user's ear
- The measurement plane is located parallel to the reference plane and 15 mm from it, out from the phone. The grid is located in the measurement plane.

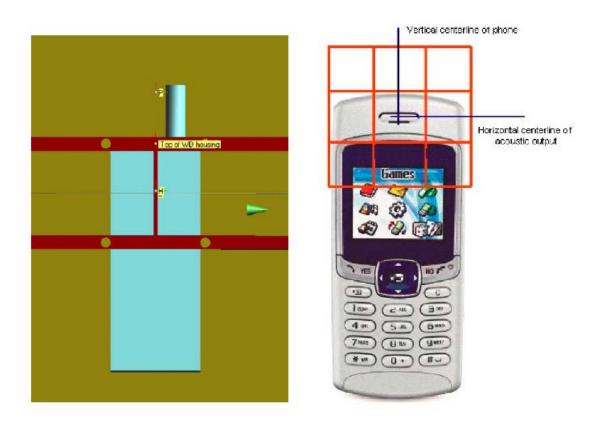


Fig. 3 WD reference and plane for RF emission measurements

8 SYSTEM VALIDATION

8.1 Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna



- The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions
- The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements.

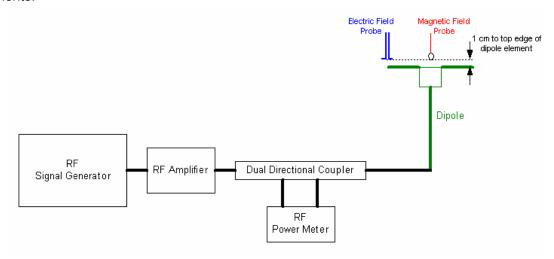


Fig. 4 Dipole Validation Setup

8.2 Validation Result

	E-Field Scan										
Mode	Frequency	Input	Power	Measured ¹	Measured ¹ Target ² Deviation ³		Limit ⁴				
	(MHz)	(mW)		Value(V/m)	Value(V/m)	(%)	(%)				
CW	835	100		162.9	160.4	1.56	±25				
CW	1880	100		143.9	138.9	3.60	±25				
				H-Field Scan							
Mode	Frequency	Input	Power	Measured	Target	Deviation	Limit				
	(MHz)	(mW)		Value(A/m)	Value(A/m)	(%)	(%)				
CW	835	100		0.465	0.461	0.87	±25				
CW	1880	100		0.464	0.463	0.22	±25				

Notes:

- 1. Please refer to the attachment for detailed measurement data and plot.
- 2. Target value is provided by SPEAD in the calibration certificate of specific dipoles.
- 3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.
- 4. ANSI C63.19 requires values within \pm 25% are acceptable, of which 12% is deviation and 13% is measurement uncertainty. Values independently validated for the dipole actually used in the measurements should be used, when available.

9 Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1). Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak



amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

9.1 Modulation Factor Test Procedure

This may be done using the following procedure:

- 1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna, as illustrated in Figure 6.
- 2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
- 3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
- 4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
- 5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
- 6. Record the reading of the probe measurement system of the unmodulated signal.
- 7. The ratio, in linear units, of the probe reading in Step 6) to the reading in Step 3) is the E-field modulation factor. $PMF_E = E_{CW} / E_{mod} (PMF_H = H_{CW} / H_{mod})$
- 8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

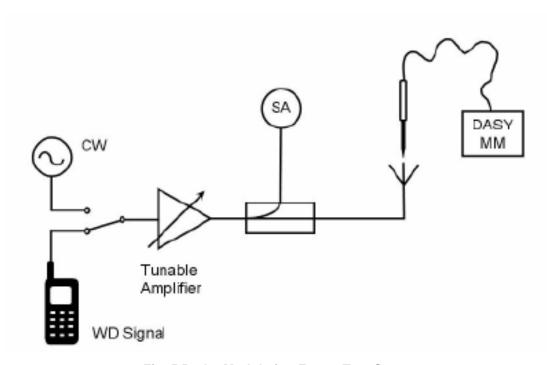


Fig. 5 Probe Modulation Factor Test Setup



9.2 Modulation Factor

9.2.1 E-Field

Frequency	Mode	Input Power	E-Field Measured Value	Probe Modulation
(MHz)		(mW)	(V/m)	Factor
835	CW	100	164.8	1
033	WCDMA	100	170.1	1.00
1880	CW	100	143.2	1
1000	WCDMA	100	136.8	1.00

9.2.2 H-Field

Frequency (MHz)	Mode	Input Power (mW)	H-Field Measured Value (A/m)	Probe Modulation Factor
835	CW	100	0.468	1
033	WCDMA	100	0.445	1.00
1990	CW	100	0.461	1
1880	WCDMA	100	0.441	1.00

10 RF TEST PROCEDUERES

The evaluation was performed with the following procedure:

- 1) Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
- 2) Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements are at different distances from the tip of the probe.
- 3) Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
- 4) The center sub-grid shall centered on the center of the T-Coil mode axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
- 5) Record the reading.
- 6) Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
- 7) Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
- 8) Identify the maximum field reading within the non-excluded sub-grids identified in Step 7)
- 9) Convert the maximum field strength reading identified in Step 8) to V/m or A/m, as appropriate.



For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.

- 10) Repeat Step 1) through Step 10) for both the E-field and H-field measurements.
- 11) Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10) for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

11 HAC RF TEST DATA SUMMARY

11.1 Measurement Results (E-Field)

Frequency		AWF	Measured Value	Power Drift	Category				
MHz	Channel		(V/m)	(dB)					
WCDMA 850									
846.6	4233	0	36.61	-0.09	M4(see Fig B.1)				
836.6	4183	0	34.25	0.00	M4(see Fig B.2)				
826.4	4132	0	30.26	-0.02	M4(see Fig B.3)				
			WCDMA 19	900					
1907.6	9538	0	9.905	-0.06	M3(see Fig B.4)				
1880	9400	0	11.94	-0.11	M3(see Fig B.5)				
1852.4	9262	0	14.82	-0.09	M3(see Fig B.6)				

11.2 Measurement Results (H-Field)

Frequency		AWF	Measured Value	Power Drift	Category						
MHz	Channel		(A/m)	(dB)							
	WCDMA 850										
846.6	4233	0	0.04968	0.06	M4(see Fig B.7)						
836.6	4183	0	0.04552	0.03	M4(see Fig B.8)						
826.4	4132	0	0.03912	0.02	M4(see Fig B.9)						
			WCDMA 19	900							
1907.6	9538	0	0.02975	-0.06	M3 (see Fig B.10)						
1880	9400	0	0.03604	-0.06	M3 (see Fig B.11)						
1852.4	9262	0	0.04571	-0.00	M3 (see Fig B.12)						

11.3 Total M-rating

Mode	Maximum value of	Maximum value of	E-Field M	H-Field M	Total M
	peak Total E-Field	Total E-Field peak Total H-Field		Rating	Rating
	(V/m)	(A/m)			
WCDMA	36.61	0.04968	M4	M4	M4(see Fig
850	30.01	0.04900	(AWF 0 dB)	(AWF 0 dB)	B.13)
WCDMA	14.82	0.04571	M4	M4	M4(see Fig
1900	14.02	0.04571	(AWF 0 dB)	(AWF 0 dB)	B.14)



12 ANSI C 63.19-2007 LIMITS

Table 1: Telephone near-field categories in linear units

Category		Telephone RF parameters < 960 MHz						
Near field	AWF	E-field emis	sions	H-field emissions				
Cotogon, M1/T1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m			
Category M1/T1	- 5	473.2 to 841.4	V/m	1.43 to 2.54	A/m			
Cotogon, MO/TO	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m			
Category M2/T2	- 5	266.1 to 473.2	V/m	0.80 to 1.43	A/m			
Cotogon, M2/T2	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m			
Category M3/T3	- 5	149.6 to 266.1	V/m	0.45 to 0.80	A/m			
Cotogon, M4/T4	0	< 199.5	V/m	< 0.60	A/m			
Category M4/T4	- 5	< 149.6	V/m	< 0.45	A/m			
Category		Telephone RF parameters > 960 MHz						
Near field	AWF	E-field emiss	sions	H-field emiss	ssions			
Category M1/T1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m			
Category Will/Ti	- 5	149.6 to 266.1	V/m	0.45 to 0.80	A/m			
	_5 0	149.6 to 266.1 112.2 to 199.5	V/m V/m	0.45 to 0.80 0.34 to 0.60	A/m A/m			
Category M1/T1 Category M2/T2								
Category M2/T2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m			
	0 -5	112.2 to 199.5 84.1 to 149.6	V/m V/m	0.34 to 0.60 0.25 to 0.45	A/m A/m			
Category M2/T2	0 -5 0	112.2 to 199.5 84.1 to 149.6 63.1 to 112.2	V/m V/m V/m	0.34 to 0.60 0.25 to 0.45 0.19 to 0.34	A/m A/m			

13 MEASUREMENT UNCERTAINTY

No.	Error source	Туре	Uncertain ty Value (%)	Prob. Dist.	k	Ci E	Ci \H	Standard Uncertain ty (%) $u_i^{'}$ (%)	Standard Uncertain ty (%) $u_i^{'}$ (%)	Degree of freedo m V _{eff} or v _i
Meas	urement System									
1	Probe Calibration	В	5.	N	1	1	1	5.1	5.1	∞
2	Axial Isotropy	В	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
3	Sensor Displacement	В	16.5	R	$\sqrt{3}$	1	0.145	9.5	1.4	∞
4	Boundary Effects	В	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	∞



5	Linearity	В	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞		
6	Scaling to Peak Envelope Power	В	2.0	R	$\sqrt{3}$	1	1	1.2	1.2	8		
7	System Detection Limit	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞		
8	Readout Electronics	В	0.3	N	1	1	1	0.3	0.3	8		
9	Response Time	В	0.8	R	$\sqrt{3}$	1	1	0.5	0.5	∞		
10	Integration Time	В	2.6	R	$\sqrt{3}$	1	1	1.5	1.5	∞		
11	RF Ambient Conditions	В	3.0	R	$\sqrt{3}$	1	1	1.7	1.7	8		
12	RF Reflections	В	12.0	R	$\sqrt{3}$	1	1	6.9	6.9	8		
13	Probe Positioner	В	1.2	R	$\sqrt{3}$	1	0.67	0.7	0.5	8		
14	Probe Positioning	Α	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	8		
15	Extra. And Interpolation	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	8		
Test	Sample Related											
16	Device Positioning Vertical	В	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	∞		
17	Device Positioning Lateral	В	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞		
18	Device Holder and Phantom	В	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	8		
19	Power Drift	В	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	8		
Phar	Phantom and Setup related											
20s	Phantom Thickness	В	2.4	R	$\sqrt{3}$	1	0.67	1.4	0.9	8		
Comb	pined standard uncertainty	(%)				•		14.7	10.9			
1	nded uncertainty dence interval of 95 %)	u,	$u_c = 2u_c$	N		k=2		29.4	21.8			



14 MAIN TEST INSTRUMENTS

Table 2: List of Main Instruments

No.	Name	Туре	Serial Number	Calibration Date	Valid Period
01	E-Field Probe	ER3DV6	2424	July 18, 2012	One year
02	H-Field Probe	H3DV6	6264	July 18, 2012	One year
03	HAC Dipole	CD835V3	1023	August 30, 2012	One year
04	HAC Dipole	CD1880V3	1018	August 30, 2012	One year
05	BTS	E5515C	GB47460133	September 20, 2012	One year
06	DAE	DAE4	786	November 20, 2012	One year

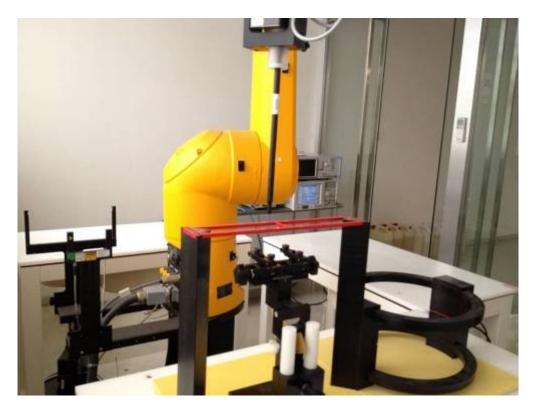
15 CONCLUSION

The HAC measurement indicates that the EUT complies with the HAC limits of the ANSI C63.19-2007. The total M-ratings are **M4** for **WCDMA 850/1900.**

END OF REPORT BODY



ANNEX A TEST LAYOUT



Picture A1: HAC RF System Layout



ANNEX B TEST PLOTS

HAC RF E-Field WCDMA 850 High

Date/Time: 3/21/2013 8:54:43 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850_Band V;

Frequency: 846.6 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W850 Channel High/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

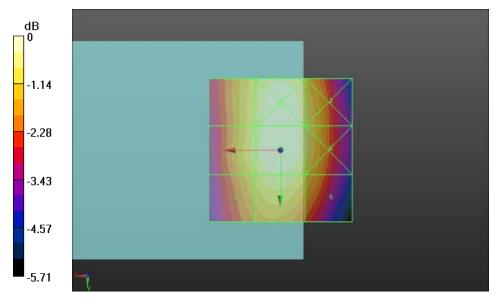
Reference Value = 48.80 V/m; Power Drift = -0.09 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 36.61 V/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 34.02 V/m	
Grid 4 M4 34.63 V/m	
Grid 7 M4 33.02 V/m	



0 dB = 36.61 V/m = 31.27 dBV/m

Fig B.1 HAC RF E-Field WCDMA 850 High



HAC RF E-Field WCDMA 850 Middle

Date/Time: 3/21/2013 9:03:42 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850 Band V;

Frequency: 836.6 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W850 Channel Mid/Hearing Aid Compatibility Test (101x101x1): Interpolated grid:

dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 45.63 V/m; Power Drift = 0.00 dB

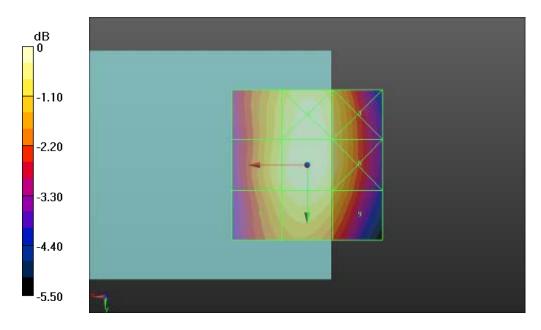
PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 34.25 V/m

Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 M4 31.55 V/m	
Grid 4 M4 32.24 V/m	
Grid 7 M4 31.12 V/m	



0 dB = 34.25 V/m = 30.69 dBV/m

Fig B.2 HAC RF E-Field WCDMA 850 Middle



HAC RF E-Field WCDMA 850 Low

Date/Time: 3/21/2013 9:09:24 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850 Band V;

Frequency: 826.4 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W850 Channel Low/Hearing Aid Compatibility Test (101x101x1): Interpolated grid:

dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

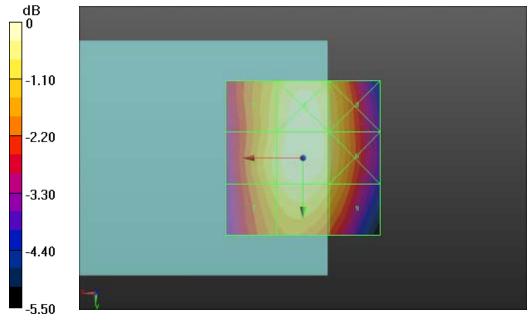
Reference Value = 40.49 V/m; Power Drift = -0.02 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 30.26 V/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 27.89 V/m	
Grid 4 M4 28.51 V/m	
Grid 7 M4 27.66 V/m	



0 dB = 30.26 V/m = 29.62 dBV/m

Fig B.3 HAC RF E-Field WCDMA 850 Low



HAC RF E-Field WCDMA 1900 High

Date/Time: 3/19/2013 9:04:28 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1908 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W1900 Channel High/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

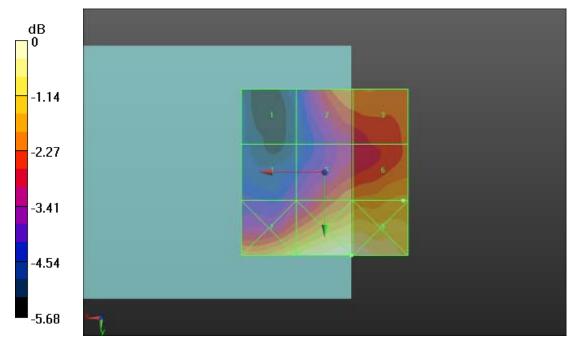
Reference Value = 9.707 V/m; Power Drift = -0.06 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 9.905 V/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 7.026 V/m	
Grid 4 M4 7.742 V/m	
Grid 7 M4 10.82 V/m	



0 dB = 11.64 V/m = 21.32 dBV/m

Fig B.4 HAC RF E-Field WCDMA 1900 High



HAC RF E-Field WCDMA1900 Middle

Date/Time: 3/19/2013 8:58:58 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1880 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W1900 Channel Mid/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

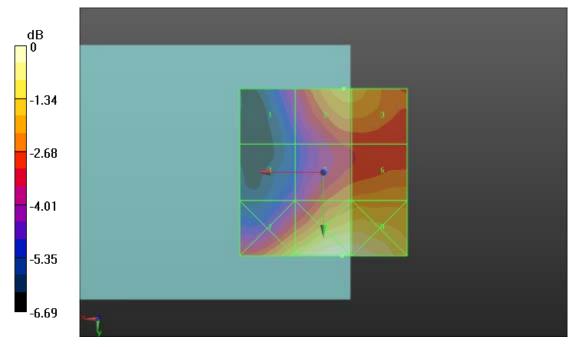
Reference Value = 11.82 V/m; Power Drift = -0.11 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 11.94 V/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 9.205 V/m	
Grid 4 M4 8.666 V/m	
Grid 7 M4 12.64 V/m	



0 dB = 14.17 V/m = 23.03 dBV/m

Fig B.5 HAC RF E-Field WCDMA 1900 Middle



HAC RF E-Field WCDMA 1900 Low

Date/Time: 3/19/2013 9:09:51 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1852.4 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W1900 Channel Low/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

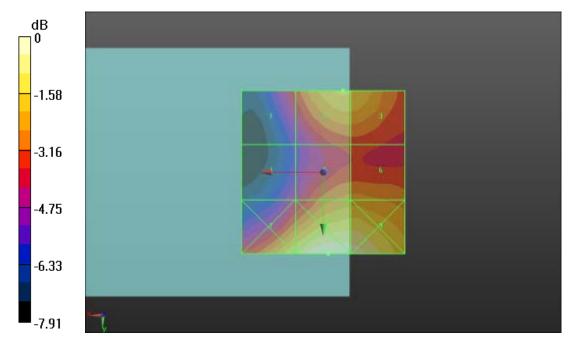
Reference Value = 14.15 V/m; Power Drift = -0.09 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 14.82 V/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 11.71 V/m	
Grid 4 M4 10.55 V/m	
Grid 7 M4 15.88 V/m	



0 dB = 17.51 V/m = 24.87 dBV/m

Fig B.6 HAC RF E-Field WCDMA 1900 Low



HAC RF H-Field WCDMA 850 High

Date/Time: 3/21/2013 9:40:27 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850 Band V;

Frequency: 846.6 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W850 Channel High/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

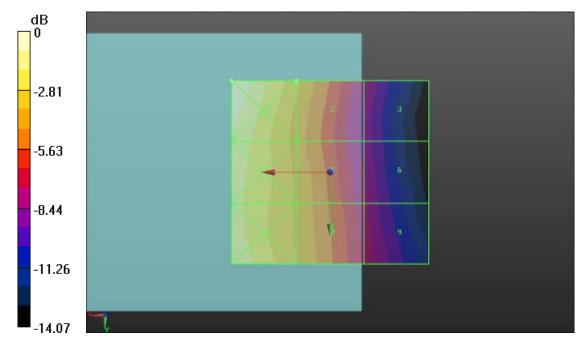
Reference Value = 0.04000 A/m; Power Drift = 0.06 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.04968 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.075 A/m	0.050 A/m	0.028 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.066 A/m	0.048 A/m	0.029 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.068 A/m	0.049 A/m	0.031 A/m



0 dB = 0.07453 A/m = -22.55 dBA/m

Fig B.7 HAC RF H-Field WCDMA 850 High



HAC RF H-Field WCDMA 850 Middle

Date/Time: 3/21/2013 9:27:38 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850 Band V;

Frequency: 836.6 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W850 Channel Middle/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

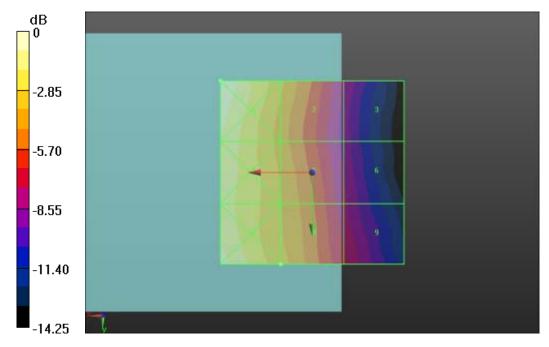
Reference Value = 0.03600 A/m; Power Drift = 0.03 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.04552 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 0.068 A/m	
Grid 4 M4 0.060 A/m	
Grid 7 M4 0.064 A/m	



0 dB = 0.06751 A/m = -23.41 dBA/m

Fig B.8 HAC RF H-Field WCDMA 850 Middle



HAC RF H-Field WCDMA 850 Low

Date/Time: 3/21/2013 9:34:38 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850 Band V;

Frequency: 826.4 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W850 Channel Low/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

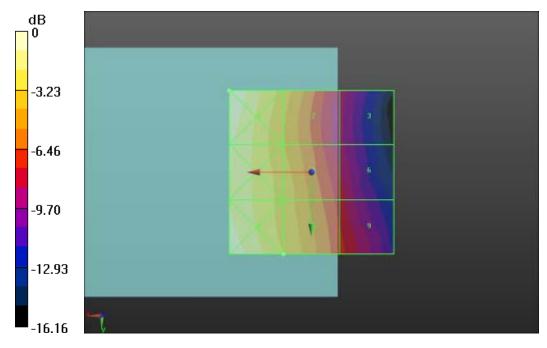
Reference Value = 0.03000 A/m; Power Drift = 0.02 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.03912 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.057 A/m	0.037 A/m	0.020 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.051 A/m	0.037 A/m	0.023 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.056 A/m	0.039 A/m	0.025 A/m



0 dB = 0.05671 A/m = -24.93 dBA/m

Fig B.9 HAC RF H-Field WCDMA 850 Low



HAC RF H-Field WCDMA 1900 High

Date/Time: 3/19/2013 9:32:52 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1908 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W1900 Channel High/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.03000 A/m; Power Drift = -0.06 dB

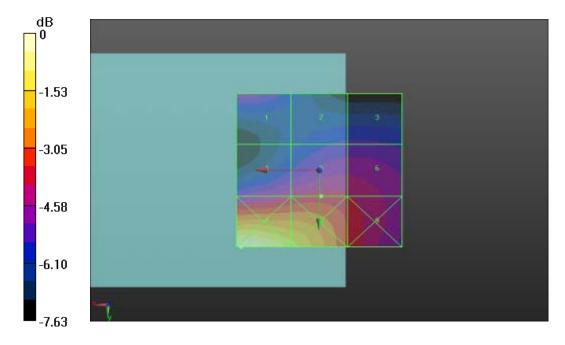
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.02975 A/m

Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

Grid 1 M4 0.027 A/m	
Grid 4 M4 0.029 A/m	
Grid 7 M4 0.046 A/m	



0 dB = 0.04610 A/m = -26.73 dBA/m

Fig B.10 HAC RF H-Field WCDMA 1900 High



HAC RF H-Field WCDMA 1900 Middle

Date/Time: 3/19/2013 9:27:46 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1880 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W1900 Channel Middle/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

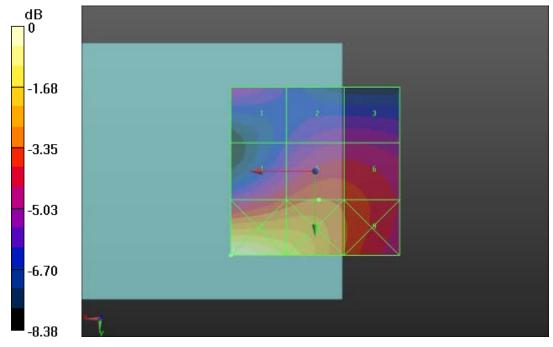
Reference Value = 0.03800 A/m; Power Drift = -0.06 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.03604 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.030 A/m	0.030 A/m	0.030 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.034 A/m	0.036 A/m	0.035 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.053 A/m	0.046 A/m	0.036 A/m



0 dB = 0.05260 A/m = -25.58 dBA/m

Fig B.11 HAC RF H-Field WCDMA 1900 Middle



HAC RF H-Field WCDMA 1900 Low

Date/Time: 3/19/2013 9:38:16 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1852.4 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W1900 Channel Low/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

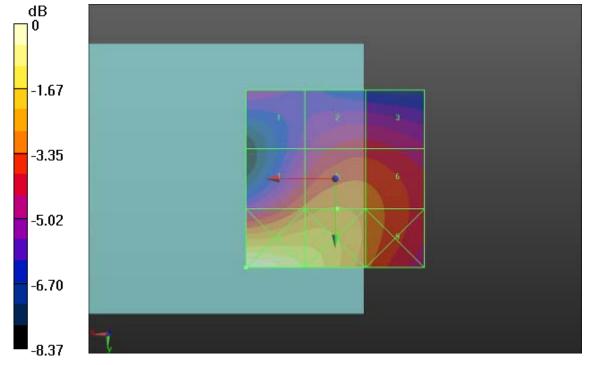
Reference Value = 0.05000 A/m; Power Drift = -0.00 dB

PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.04571 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 0.035 A/m	
Grid 4 M4 0.044 A/m	
Grid 7 M4 0.063 A/m	



0 dB = 0.06262 A/m = -24.07 dBA/m

Fig B.12 HAC RF H-Field WCDMA 1900 Low



Total M-rating of WCDMA 850 MHz Band

Date/Time: 3/21/2013 8:54:43 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W850 Band V;

Frequency: 846.6 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W850 Channel High/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 48.80 V/m; Power Drift = -0.09 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 36.61 V/m

Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 M4 34.02 V/m	
Grid 4 M4 34.63 V/m	
Grid 7 M4 33.02 V/m	

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W850 Channel High/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.04000 A/m; Power Drift = 0.06 dB

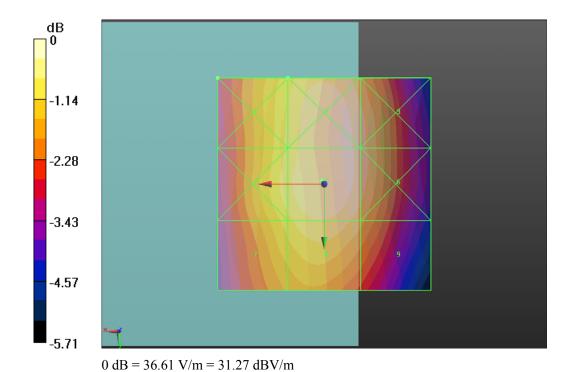
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.06808 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.075 A/m	0.050 A/m	0.028 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.066 A/m	0.048 A/m	0.029 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.068 A/m	0.049 A/m	0.031 A/m





E-Field M Rating M4 (AWF 0dB)

RF RESULTS AND M-RATING H-Field M Rating M4 (AWF 0dB)

Total M Rating M4

Fig B.13 Total M-rating of WCDMA 850



Total M-rating of WCDMA 1900 MHz Band

Date/Time: 3/19/2013 9:09:51 PM

Electronics: DAE4 Sn786

Medium: Air

Communication System: WCDMA; Communication System Band: W1900 Band II;

Frequency: 1852.4 MHz; Communication System PAR: 0 dB; PMF: 1

Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Device E-Field measurement (E-field scan for ANSI C63.19-2007 & -2011 compliance)/E Scan W1900 Channel Low/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 14.15 V/m; Power Drift = -0.09 dB

PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 14.82 V/m

Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 M4 11.71 V/m	
Grid 4 M4 10.55 V/m	
Grid 7 M4 15.88 V/m	

Device H-Field measurement with H3DV6 probe (H-field scan for ANSI C63.19-2007 compliance)/H Scan W1900 Channel Low/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.05000 A/m; Power Drift = -0.00 dB

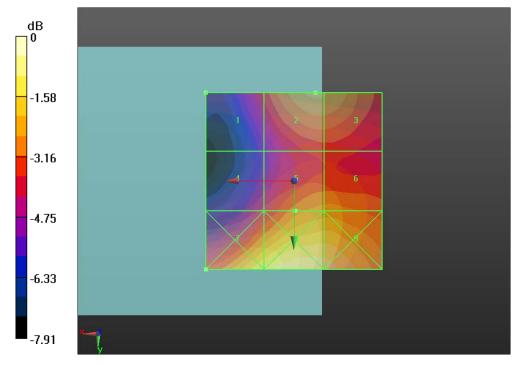
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.04571 A/m

Near-field category: M4 (AWF 0 dB)

Grid 1 M4 0.035 A/m	
Grid 4 M4 0.044 A/m	
Grid 7 M4 0.063 A/m	





0 dB = 17.51 V/m = 24.87 dBV/m

	Total M Rating	M4
RF RESULTS AND M-RATING	H-Field M Rating	M4 (AWF 0 dB)
	E-Field M Rating	M4 (AWF 0 dB)

Fig B.14 Total M-rating of WCDMA 1900



ANNEX C SYSTEM VALIDATION RESULT

E SCAN of Dipole 835 MHz

Date: 3/21/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon r = 1$; $\rho = 0$ kg/m³

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 162.9 V/m

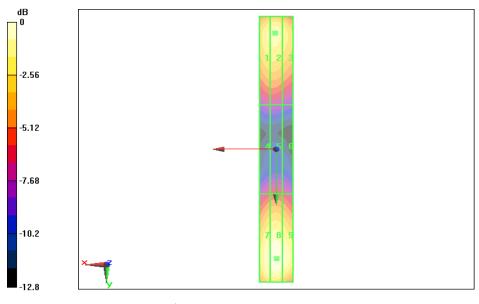
Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 106.9 V/m; Power Drift = 0.054 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
158.6 M4	162.9M4	149.6 M4
Grid 4	Grid 5	Grid 6
88.1 M4	90.5 M4	88.2 M4
Grid 7	Grid 8	Grid 9
153.3 M4	162.1 M4	159.7 M4



0 dB = 162.5 V/m

Fig B.15 E SCAN of Dipole 835 MHz



H SCAN of Dipole 835 MHz

Date: 3/21/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon r = 1$; $\rho = 0$ kg/m³

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Probe: H3DV6 - SN6264

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.465 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.496 A/m; Power Drift = -0.03 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.386 M4	0.406 M4	0.396 M4
Grid 4	Grid 5	Grid 6
0.434M4	0.465 M4	0.441 M4
Grid 7	Grid 8	Grid 9
0.377 M4	0.404 M4	0.396 M4

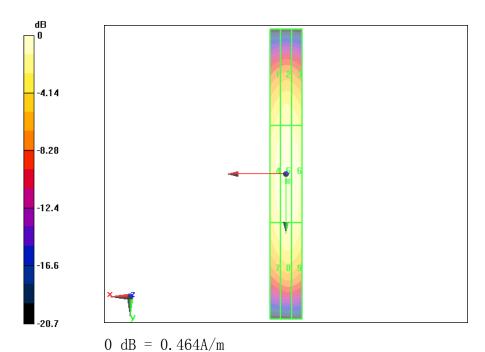


Fig B.16 H SCAN of Dipole 835 MHz



E SCAN of Dipole 1880 MHz

Date: 3/19/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1 Probe: ER3DV6 - SN2424 ConvF(1, 1, 1); Calibrated: 7/18/2012

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 143.9 V/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 161.5 V/m; Power Drift = -0.045 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
134.8 M2	139.2 M2	138.0 M2
Grid 4	Grid 5	Grid 6
90.5 M3	93.6 M3	90.7 M3
Grid 7	Grid 8	Grid 9
134.5 M2	143.9 M2	142.2 M2

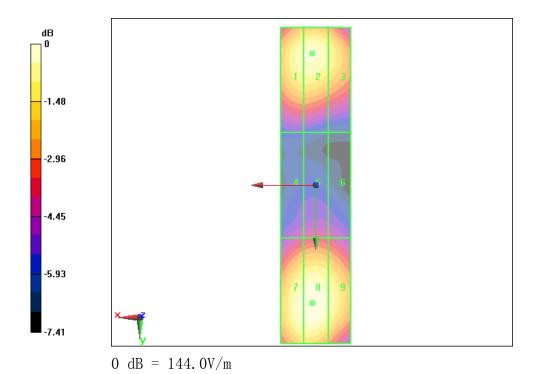


Fig B.17 E SCAN of Dipole 1880 MHz



H SCAN of Dipole 1880 MHz

Date: 3/19/2013

Electronics: DAE4 Sn786

Medium: Air

Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m³

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Probe: H3DV6 - SN6264

H Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.464 A/m

Probe Modulation Factor = 1

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.491 A/m; Power Drift = 0.061 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.394 M2	0.425 M2	0.396 M2
Grid 4	Grid 5	Grid 6
0.442 M2	0.464 M2	0.454 M2
Grid 7	Grid 8	Grid 9

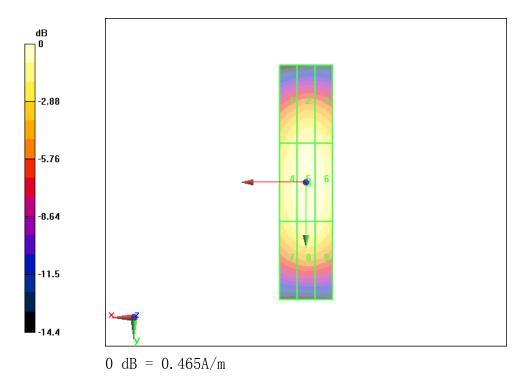
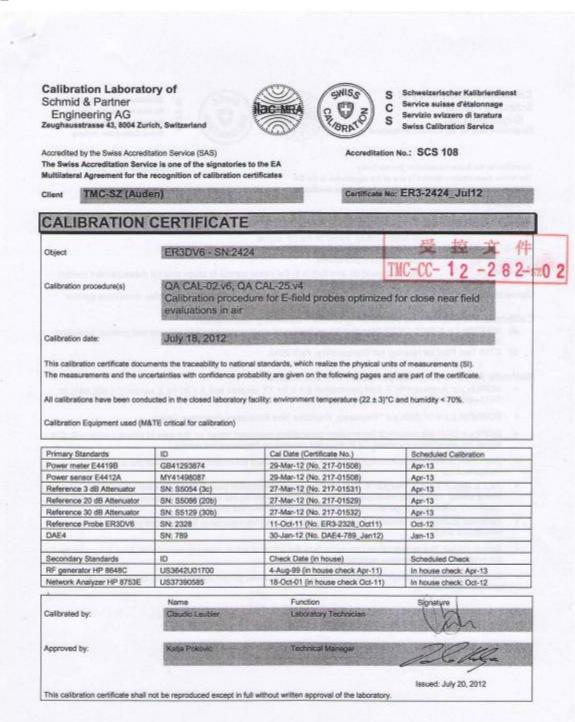


Fig B.18 H SCAN of Dipole 1880 MHz



ANNEX D PROBE CALIBRATION CERTIFICATE

E_Probe:ER3DV6







Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S

C

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point

CF. crest factor (1/duty_cycle) of the RF signal A, B, C modulation dependent linearization parameters

Polarization e φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

information used in DASY system to align probe sensor X to the robot coordinate system Connector Angle

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005

b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 8 = 0 for XY sensors and 8 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- $NORM(f)x,y,z = NORMx,y,z * frequency_response$ (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).



ER3DV6 - SN:2424

July 18, 2012

Probe ER3DV6

SN:2424

Manufactured: Calibrated: November 12, 2007

July 18, 2012

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)



ER3DV6-- SN:2424

July 18, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Basic Calibration Parameters

No.	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m) ²)	1.52	1.53	1.87	± 10.1 %
DCP (mV) ⁸	98.6	100.0	99.8	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^c (k=2)
0	CW	0.00	X	0.00	0.00	1.00	192.9	±4.1 %
			Y	0.00	0.00	1.00	207.9	
			Z	0.00	0.00	1.00	201.5	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

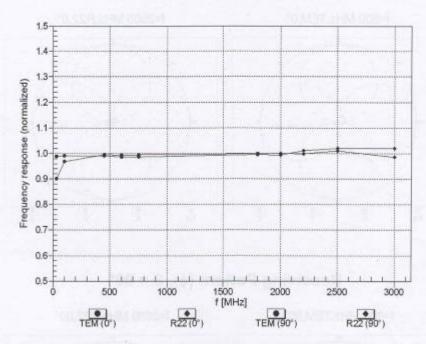
Numerical linearization parameter: uncertainty not required.
E Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



ER3DV6-SN:2424

July 18, 2012

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)



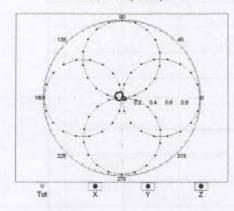


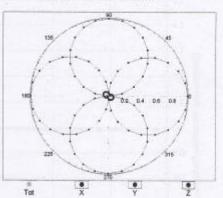
July 18, 2012

Receiving Pattern (ϕ), $\theta = 0^{\circ}$

f=600 MHz,TEM,0°

f=2500 MHz,R22,0°

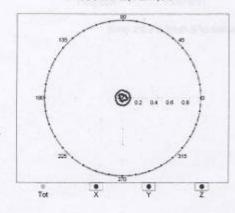


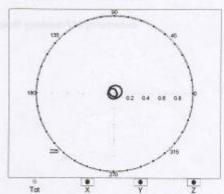


Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$

f=600 MHz,TEM,90°

f=2500 MHz,R22,90°



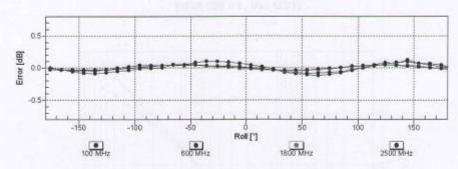




ER3DV6-SN:2424

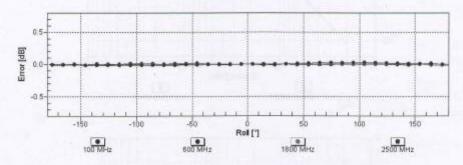
July 18, 2012

Receiving Pattern (\$\phi\$), 9 = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (\$\phi\$), \$\partial = 90°

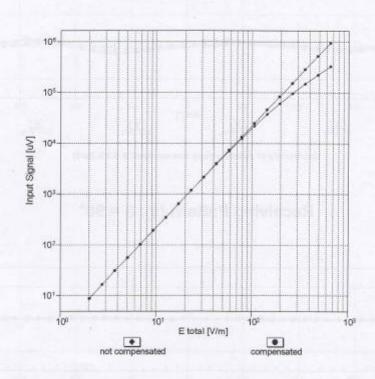


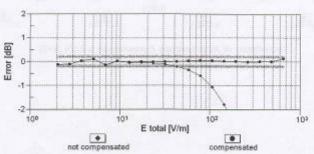
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)



ER3DV6- SN:2424 July 18, 2012

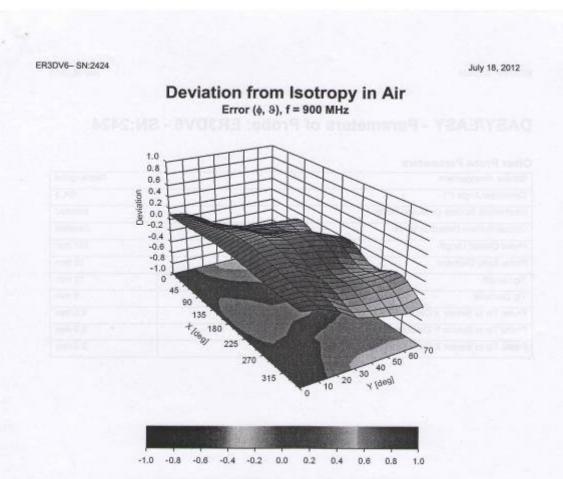
Dynamic Range f(E-field) (TEM cell , f = 900 MHz)





Uncertainty of Linearity Assessment: ± 0.6% (k=2)







ER3DV6- SN:2424

July 18, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2424

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (*)	164.3
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm



H Probe H3DV6

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Client

TMC-SZ (Auden)

Certificate No: H3-6264_Jul12

Accreditation No.: SCS 108

CALIBRATION CERTIFICATE

Object

H3DV6 - SN:6264

QA CAL-03.v6, QA CAL-25.v4

Calibration procedure for H-field probes optimized for close near field

evaluations in air

Calibration date:

Calibration procedure(s)

July 20, 2012

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Reference 3 dB Attenuator	SN: S5064 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13
Reference Probe H3DV6	SN: 6182	11-Oct-11 (No. H3-6162_Oct11)	Oct-12
DAE4	SN: 789	30-Jan-12 (No. DAE4-789_Jan12)	Jan-13
Secondary Standards	ID.	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

Calibrated by:

Name

Function

Signature

Laboratory Technician

What

Cl-Voters

Approved by:

Katja Pokovic

Technical Manager

Issued: July 23, 2012

This calibration certificate shall not be reproduced except in full without written approval of the laboratory



Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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C Service suisse d'étalonnage
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Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z sensitivity in free space DCP diode compression point

CF crest factor (1/duty_cycle) of the RF signal A, B, C modulation dependent linearization parameters

Polarization ϕ ϕ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 8 = 0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

 EEE Std 1309-2005, * IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz*, December 2005.

b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)_a0a1a2= X,Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z: A, B, C are numerical linearization parameters assessed based on the data of
 power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the
 maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X_a0a1a2 (no uncertainty required).

July 20, 2012



H3DV6 - SN:6264

Probe H3DV6

SN:6264

Manufactured: Calibrated: September 7, 2007 July 20, 2012

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)



H3DV6-SN:6264

July 20, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6264

Basic Calibration Parameters

	111111111111111111111111111111111111111	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (A/m / √(mV))	a0	2.48E-003	2.55E-003	2.95E-003	±5.1%
Norm (A/m / √(mV))	a1	-7.25E-005	-6.92E-005	-9.44E-005	± 5.1 %
Norm (A/m / √(mV))	a2	2.96E-005	8.62E-006	3.28E-005	± 5.1 %
DCP (mV) ⁸		92.7	91.3	90.0	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^b (k=2)
0	CW	0.00	X	0.00	0.00	1.00	140.6	±4.4 %
			Y	0.00	0.00	1.00	137.4	
			Z	0.00	0.00	1.00	137.5	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

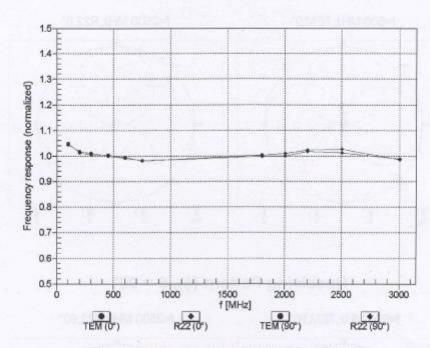
Numerical linearization parameter: uncertainty not required.
E Uncertainty is determined using the max: deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



H3DV6- SN:6264

July 20, 2012

Frequency Response of H-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



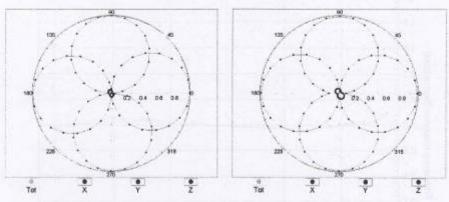
Uncertainty of Frequency Response of H-field: ± 6.3% (k=2)



H3DV6- SN:6264 July 20, 2012

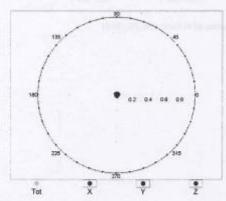
Receiving Pattern (\$\phi\$), 9 = 0°

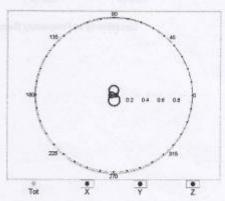
f=600 MHz,TEM,0° f=2500 MHz,R22,0°



Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$

f=600 MHz,TEM,90° f=2500 MHz,R22,90°



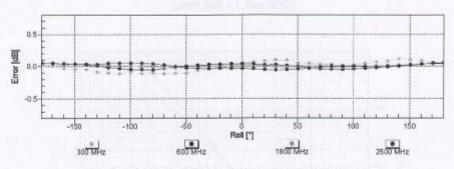




H3DV6-SN:6264

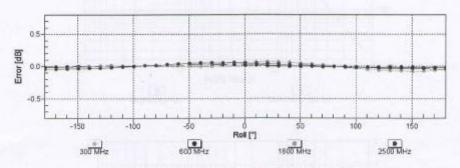
July 20, 2012

Receiving Pattern (\$\phi\$), \$\theta = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (φ), θ = 90°



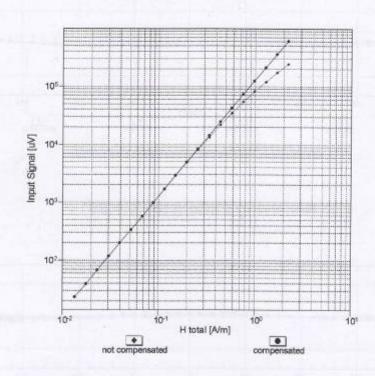
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

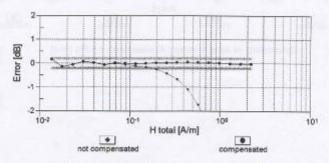


H3DV6-SN:6264

July 20, 2012

Dynamic Range f(H-field) (TEM cell, f = 900 MHz)





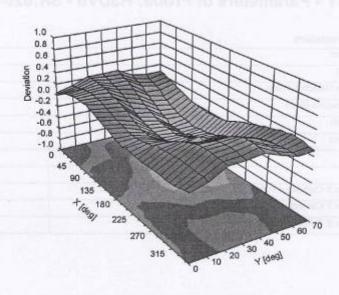
Uncertainty of Linearity Assessment: ± 0.6% (k=2)





July 20, 2012

Deviation from Isotropy in Air Error (ø, ৪), f = 900 MHz





Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)



H3DV6-- SN:6264

July 20, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6264

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (*)	-49.6
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	20 mm
Tip Diameter	6 mm
Probe Tip to Sensor X Calibration Point	3 mm
Probe Tip to Sensor Y Calibration Point	3 mm
Probe Tip to Sensor Z Calibration Point	3 mm



ANNEX E DIPOLE CALIBRATION CERTIFICATE

835MHz







Schweizerischer Kalibrierdienst Service suisse d'étalonnage C Servizio svizzero di taratura S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

CALIBRATION	CERTIFICAT	EIA-SIA DIES	10 H 30 W 40
Object	CD835V3 - SN:	1023	
Calibration procedure(s)	QA CAL-20.v6 Calibration process	edure for dipoles in air	
Calibration date:	August 30, 2012		
		probability are given on the following pages and	
		cry facility: environment temperature (22 ± 3)°C	
Calibration Equipment used (M&		Cal Date (Certificate No.)	Scheduled Calibration
Calibration Equipment used (Mil Primary Standards Power moter EPM-442A	RTE critical for calibration) ID # GB37480704	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451)	Scheduled Calibration Oct-12
Calibration Equipment used (M8 Primary Standards Power moter EPM-442A Power sensor HP 8481A	ID W GB37480704 US37292783	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451)	Scheduled Calibration Oct-12 Oct-12
Calibration Equipment used (M8 Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6	ID W GB37480704 US37292783 SN: 2336	Cal Date (Certificate No.) 05-Dct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11)	Scheduled Calibration Oct-12 Oct-12 Dec-12
Calibration Equipment used (M8 Primary Standards Power mater EPM-442A Power sensor HP 8481A Probe ER3DV6	ID W GB37480704 US37292783 SN: 2336 SN: 6086	Cal Date (Certificate No.) 05-Dct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 28-Dec-11 (No. H3-6065_Dec11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12
Calibration Equipment used (M& Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6	ID W GB37480704 US37292783 SN: 2336	Cal Date (Certificate No.) 05-Dct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11)	Scheduled Calibration Oct-12 Oct-12 Dec-12
Calibration Equipment used (M& Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4	ID W GB37480704 US37292783 SN: 2336 SN: 6086	Cal Date (Certificate No.) 05-Dct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 28-Dec-11 (No. H3-6065_Dec11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12
Calibration Equipment used (M& Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe HSDV6 DAE4	ID W GB37480704 US37292783 SN: 2336 SN: 8085 SN: 781	Cal Date (Certificate No.) 05-Dct-11 (No. 217-01451) 05-Dct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336 Dec11) 29-Dec-11 (No. H3-6065 Dec11) 29-May-12 (No. DAE4-781_May12)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 May-13 Scheduled Check In house check: Oct-12
Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198	ID W GB37480704 US37292763 SN: 2336 SN: 6066 SN: 781 ID # SN: GB42420191 SN: 3318A09450	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 29-May-12 (No. DAE4-781_May12) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 May-13 Scheduled Check In house check: Oct-12 In house check: Oct-12
Calibration Equipment used (M&Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 4419B Power sensor HP 8482H Power sensor HP 8482H	ID # GB37480704 US37292783 SN: 2336 SN: 6085 SN: 781 ID # SN: GB42420191 SN: 3318A09450 SN: US37296597	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 29-May-12 (No. DAE4-781_May12) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 May-13 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12
Calibration Equipment used (M&Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8753E	ID # GB37480704 US37292763 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: 3318A09450 SN: US37296597 US37390585	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 29-May-12 (No. DAE4-781_May12) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 May-13 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12
Calibration Equipment used (M&Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power sensor HP 8482H	ID # GB37480704 US37292783 SN: 2336 SN: 6085 SN: 781 ID # SN: GB42420191 SN: 3318A09450 SN: US37296597	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 29-May-12 (No. DAE4-781_May12) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 May-13 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12
Calibration Equipment used (M&Primary Standards Power moter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4 Secondary Standards Power meter Agilent 44198 Power sensor HP 8482H Power sensor HP 8482A Network Analyzer HP 8753E	ID # GB37480704 US37292763 SN: 2336 SN: 6065 SN: 781 ID # SN: GB42420191 SN: 3318A09450 SN: US37296597 US37390585	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. ER3-2336_Dec11) 29-Dec-11 (No. H3-6065_Dec11) 29-May-12 (No. DAE4-781_May12) Check Date (in house) 09-Oct-09 (in house check Oct-11) 09-Oct-09 (in house check Oct-11) 18-Oct-01 (in house check Oct-11)	Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 May-13 Scheduled Check In house check: Oct-12 In house check: Oct-12 In house check: Oct-12 In house check: Oct-12
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Certificate No: CD835V3-1023_Aug12

Page 1 of 6





Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Schweizerischer Kalibrierdienst Service sulase d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

 ANSI-C63, 19-2007
 American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms, z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms, x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.



Measurement Conditions

DASY system configuration, as far as not given on page 1.

The state of the s	
Advanced Extrapolation	
HAC Test Arch	
10mm	
dx, dy = 5 mm	
835 MHz ± 1 MHz	
< 0.05 dB	
	10mm dx, dy = 5 mm 835 MHz ± 1 MHz

Maximum Field values at 835 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.461 A / m ± 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	161.8 V / m
Maximum measured above low end	100 mW input power	159.0 V / m
Averaged maximum above arm	100 mW input power	160.4 V / m ± 12.8 % (k=2)

Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	16.2 dB	45.1 Ω - 14.1 jΩ
835 MHz	29.5 dB	49.6 Ω + 3.3 jΩ
900 MHz	16.7 dB	59.4 Ω - 13.1 jΩ
950 MHz	26.0 dB	46.0 Ω + 2.7 jΩ
960 MHz	19.3 dB	51.1 Ω + 10.9 jΩ

3.2 Antenna Design and Handling

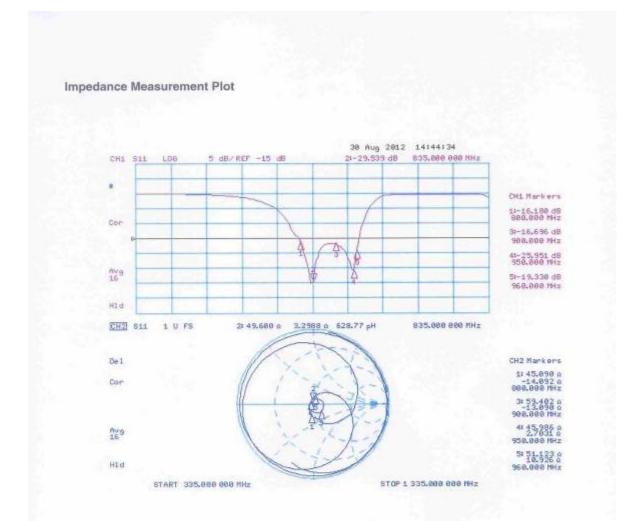
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.







DASY5 H-field Result

Date: 30.08,2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 5n781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

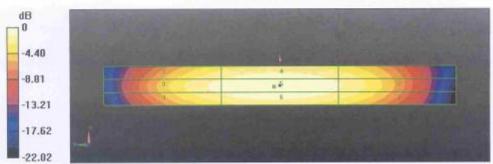
Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm
Device Reference Point; 0, 0, -6.3 mm
Reference Value = 0.49 V/m; Power Drift = 0.01 dB
PMR not calibrated. PMF = 1.000 is applied.
H-field emissions = 0.46 A/m

Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.38 A/m	0.40 A/m	0.38 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.43 A/m	0.46 A/m	0.44 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.39 A/m	0.42 A/m	0.40 A/m



0 dB = 0.461A/m = -6.74 dB A/m



DASY5 E-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma=0$ mho/m, $\epsilon_r=1$; $\rho=1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

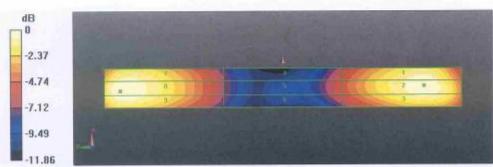
- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- · Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid; dx=5mm, dy=5mm
Device Reference Point; 0, 0, -6.3 mm
Reference Value = 104.0 V/m; Power Drift = -0.04 dB
PMR not calibrated. PMF = 1.000 is applied.
E-field emissions = 161.8 V/m
Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
156.0 V/m	159.0 V/m	151.3 V/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
87.06 V/m	88.87 V/m	85.39 V/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
154.8 V/m	161.8 V/m	159.2 V/m



0 dB = 161.8V/m = 44.18 dB V/m



1880MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 108

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

bject	CD1880V3 - SN	: 1018	
alibration procedure(s)	QA CAL-20,v6 Calibration proc	edure for dipoles in air	
alibration date:	August 30, 2012		
		ional standards, which realize the physical uni probability are given on the following pages an	
Il calibrations have been condu	acted in the closed laborate	ory facility: environment temperature (22 ± 3)°C	and humidity < 70%.
il calibrations have been conducation Equipment used (M8		ory facility: environment temperature (22 \pm 3)°C	C and humidity < 70%.
alibration Equipment used (M8		ory facility: environment temperature (22 ± 3)*C Gal Date (Certificate No.)	and humidity < 70%. Scheduled Calibration
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Certificate No: CD1880V3-1018_Aug12

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
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Accreditation No.: SCS 108

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The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna
 (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes.
 In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a
 distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.



Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.2
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1880 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.463 A / m ± 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	139.0 V / m
Maximum measured above low end	100 mW input power	138.8 V / m
Averaged maximum above arm	100 mW input power	138.9 V / m ± 12.8 % (k=2)

Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
1730 MHz	27.8 dB	52.8 Ω + 3.1 jΩ
1880 MHz	21.7 dB	49.4 Ω + 8.2 jΩ
1900 MHz	22.2 dB	51.6 Ω + 7.7 jΩ
1950 MHz	30.1 dB	52.3 Ω + 2.3 jΩ
2000 MHz	20.7 dB	$42.8 \Omega + 4.7 j\Omega$

3.2 Antenna Design and Handling

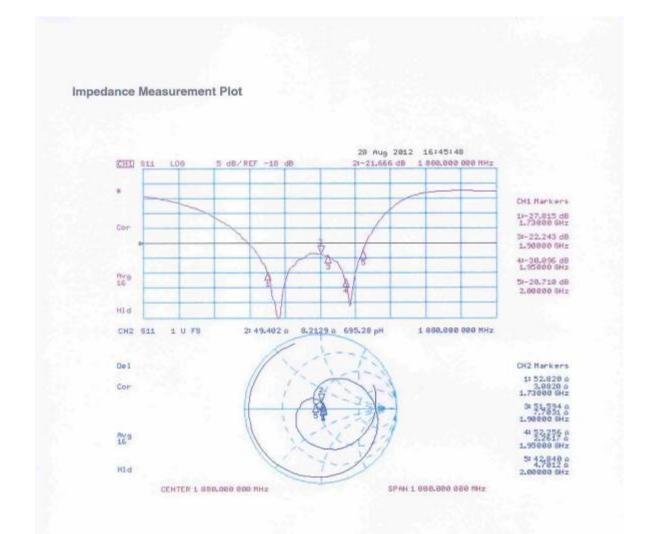
The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.







DASY5 H-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma=0$ mho/m, $\epsilon_r=1$; $\rho=1$ kg/m³ Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

Probe: H3DV6 - SN6065; ; Calibrated: 29.12.2011

· Sensor-Surface: (Fix Surface)

Electronics: DAE4 Sn781; Calibrated: 29.05.2012

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070

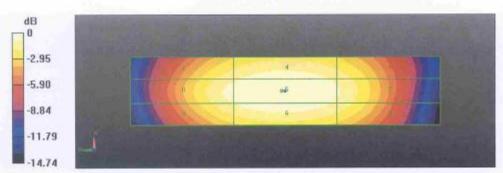
DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dípole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 0.49 V/m; Power Drift = 0.03 dB
PMR not calibrated. PMF = 1.000 is applied.
H-field emissions = 0.46 A/m
Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
0.40 A/m	0.42 A/m	0.40 A/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
0.44 A/m	0.46 A/m	0.44 A/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
0.40 A/m	0.43 A/m	0.41 A/m



0 dB = 0.463A/m = -6.74 dB A/m



DASY5 E-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma=0$ mho/m, $\epsilon_r=1$; $\rho=1000$ kg/m 3 Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

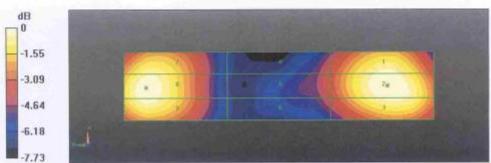
- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 156.8 V/m; Power Drift = 0.01 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 139.0 V/m Near-field category: M2 (AWF 0 dB)

PMF scaled E-field

STATE OF THE PARTY	Grid 2 M2 138.8 V/m	CONTRACTOR OF THE
Grid 4 M3	Grid 5 M3 93.60 V/m	Grid 6 M3
	Grid 8 M2 139.0 V/m	



0 dB = 139.0V/m = 42.86 dB V/m